

# PC8171xNSZ0F Series

# DIP 4pin High CMR, Low Input Current Photocoupler



#### ■ Description

**PC8171xNSZ0F Series** contains an IRED optically coupled to a phototransistor.

It is packaged in a 4pin DIP, available in SMT gullwing lead-form option.

Input-output isolation voltage(rms) is 5.0kV.

Collector-emitter voltage is 80V, CTR is 100% to 600% at input current of 0.5mA and CMR is MIN.  $10kV/\mu s$ .

#### **■** Features

- 1. 4pin DIP package
- Double transfer mold package (Ideal for Flow Soldering)
- 3. Low input current type (I<sub>F</sub>=0.5mA)
- 4. High collector-emitter voltage(V<sub>CEO</sub>: 80V)
- 5. High noise immunity due to high common rejection voltage (CMR : MIN.  $10kV/\mu s$ )
- 6. High isolation voltage between input and output (V<sub>iso(rms)</sub>: 5.0 kV)
- 7. Lead-free and RoHS directive compliant

#### ■ Agency approvals/Compliance

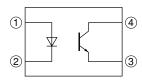
- Recognized by UL1577 (Double protection isolation), file No. E64380 (as model No. PC8171)
- 2. Package resin: UL flammability grade (94V-0)

#### Applications

- 1. Programmable controllers
- 2. Facsimiles
- 3. Telephones



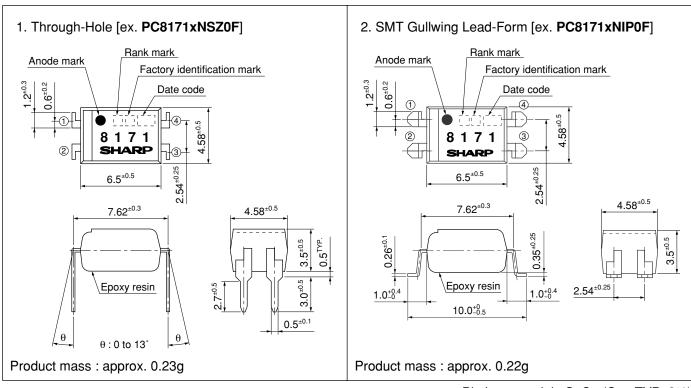
## ■ Internal Connection Diagram



- 1) Anode
- ② Cathode
- 3 Emitter
- 4 Collector

#### **■** Outline Dimensions

(Unit: mm)



Plating material: SnCu (Cu: TYP. 2%)



# Date code (2 digit)

	1st o	digit		2nd digit		
	Year of p	roduction		Month of production		
A.D.	Mark	A.D	Mark	Month	Mark	
1990	A	2002	P	January	1	
1991	В	2003	R	February	2	
1992	С	2004	S	March	3	
1993	D	2005	T	April	4	
1994	Е	2006	U	May	5	
1995	F	2007	V	June	6	
1996	Н	2008	W	July	7	
1997	J	2009	X	August	8	
1998	K	2010	A	September	9	
1999	L	2011	В	October	0	
2000	M	2012	С	November	N	
2001	N	:	:	December	D	

repeats in a 20 year cycle

# Factory identification mark

Factory identification Mark	Country of origin	
no mark	Japan	
	Indonesia	
	China	

<sup>\*</sup> This factory making is for identification purpose only. Please contact the local SHARP sales representative to see the actual status of the production.

#### Rank mark

Refer to the Model Line-up table



■ Absolute Maximum Ratings $(T_a=25^{\circ}C)$						
	Parameter	Symbol	Rating	Unit		
	Forward current	$I_F$	10	mA		
Ħ	*1 Peak forward current	$I_{FM}$	200	mA		
Input	Reverse voltage	$V_R$	6	V		
	Power dissipation	P	15	mW		
	Collector-emitter voltage	$V_{CEO}$	80	V		
Output	Emitter-collector voltage	V <sub>ECO</sub>	6	V		
Out	Collector current	$I_{C}$	50	mA		
	Collector power dissipation	$P_{C}$	150	mW		
	Γotal power dissipation	$P_{tot}$	170	mW		
*2 I	solation voltage	V <sub>iso (rms)</sub>	5.0	kV		
	Operating temperature	Topr	-30 to +100	°C		
- 5	Storage temperature	T <sub>stg</sub>	-55 to +125	°C		
*3 (	Soldering temperature	$T_{sol}$	260	°C		

<sup>\*1</sup> Pulse width≤100µs, Duty ratio : 0.001 \*2 40 to 60%RH, AC for 1 minute, f=60Hz \*3 For 10s

# **■** Electro-optical Characteristics

 $(T_a=25^{\circ}C)$ 

						$(1_{a}-25\mathbf{C})$		
Parameter			Symbol	Conditions	MIN.	TYP.	MAX.	Unit
	Forward voltage		$V_F$	I <sub>F</sub> =10mA	-	1.2	1.4	V
Input	Reverse Current		$I_R$	$V_R=4V$	-	-	10	μΑ
	Terminal capacitance		$C_t$	V=0, f=1kHz	_	30	250	pF
	Collector dark	Collector dark current		$V_{CE} = 50V, I_{F} = 0$	-	ı	100	nA
Output	Collector-emitter breakdown voltage		$\mathrm{BV}_{\mathrm{CEO}}$	$I_{C}=0.1 \text{mA}, I_{F}=0$	80	-	-	V
	Emitter-collector breakdown voltage		$BV_{ECO}$	$I_{E}=10\mu A, I_{F}=0$	6	-	-	V
	Collector current		$I_{C}$	$I_F=0.5$ mA, $V_{CE}=5$ V	0.5	_	3.0	mA
	Collector-emitter saturation voltage		$V_{\text{CE (sat)}}$	$I_F=10mA$ , $I_C=1mA$	-	ı	0.2	V
	Isolation resistance		$R_{\rm ISO}$	DC500V, 40 to 60%RH	5×10 <sup>10</sup>	1×10 <sup>11</sup>	-	Ω
Transfer characteristics	Floating capacitance		$C_{\rm f}$	V=0, f=1MHz	-	0.6	1.0	pF
	Response time F	Rise time	$t_r$	V 0V I 2 A B 1000	_	4	18	μs
		Fall time	$t_{\rm f}$	$V_{CE}=2V$ , $I_{C}=2mA$ , $R_{L}=100\Omega$	_	3	18	μs
	Common mode rejection voltage		CMR	$T_a$ =25°C, $R_L$ =470 $\Omega$ , $V_{CM}$ =1.5kV(peak) $I_F$ =0, $V_{CC}$ =9V, $V_{np}$ =100mV	10	-	-	kV/μs



# **■** Model Line-up

Lead Form	Through-Hole	SMT Gullwing		I [m A]	
Package	Sleeve	Taping	Rank mark	$I_{C}$ [mA] $(I_{F}=0.5$ mA, $V_{CE}=5$ V, $T_{a}=25$ °C)	
1 dekage	100pcs/sleeve	2 000pcs/reel			
	PC81710NSZ0F	PC81710NIP0F	with or without	0.5 to 3.0	
	PC81711NSZ0F	PC81711NIP0F	A	0.6 to 1.5	
	PC81712NSZ0F	PC81712NIP0F	В	0.8 to 2.0	
Model No.	PC81713NSZ0F	PC81713NIP0F	С	1.0 to 2.5	
	PC81715NSZ0F	PC81715NIP0F	A or B	0.6 to 2.0	
	PC81716NSZ0F	PC81716NIP0F	B or C	0.8 to 2.5	
	PC81718NSZ0F	PC81718NIP0F	A, B or C	0.6 to 2.5	

Please contact a local SHARP sales representative to inquire about production status.



Fig.1 Test Circuit for Common Mode Rejection Voltage

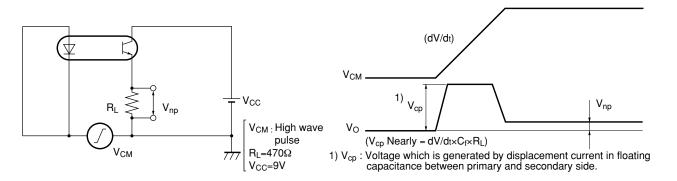


Fig.2 Forward Current vs. Ambient Temperature

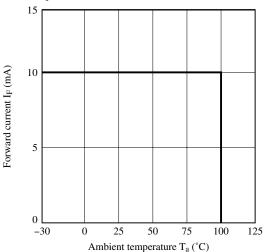


Fig.4 Collector Power Dissipation vs.
Ambient Temperature

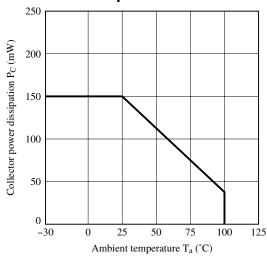


Fig.3 Diode Power Dissipation vs. Ambient Temperature

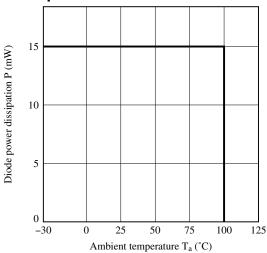
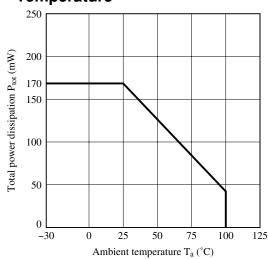


Fig.5 Total Power Dissipation vs. Ambient Temperature



Sheet No.: D2-A03302EN



Fig.6 Peak Forward Current vs. Duty Ratio

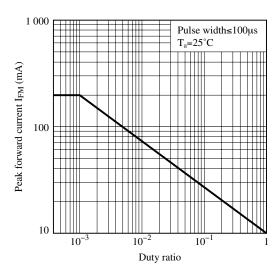


Fig.8 Current Transfer Ratio vs. Forward Current

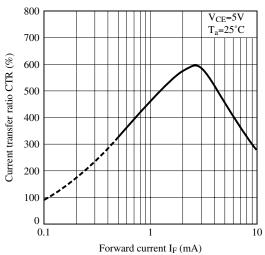


Fig.10 Relative Current Transfer Ratio vs.
Ambient Temperature

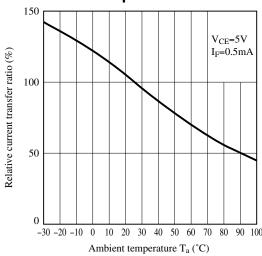


Fig.7 Forward Current vs. Forward Voltage

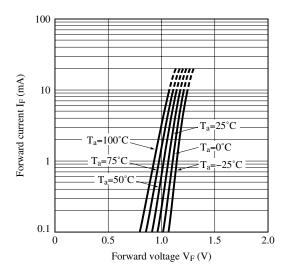


Fig.9 Collector Current vs. Collector-emitter Voltage

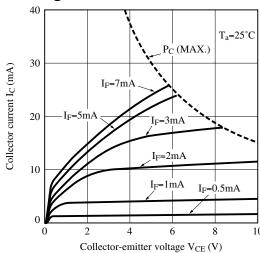


Fig.11 Collector - emitter Saturation Voltage vs. Ambient Temperature

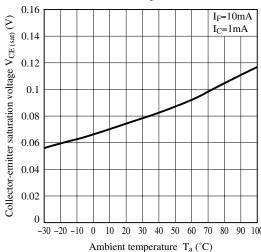




Fig.12 Collector Dark Current vs. Ambient Temperature

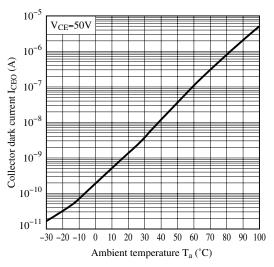


Fig.14 Response Time vs. Load Resistance (saturation region)

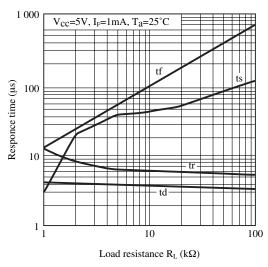


Fig.16 Frequency Response

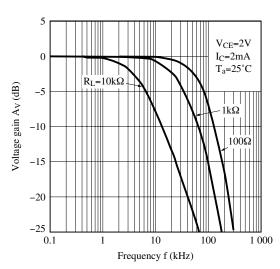


Fig.13 Response Time vs. Load Resistance (active region)

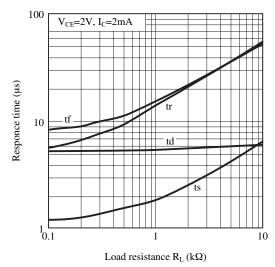
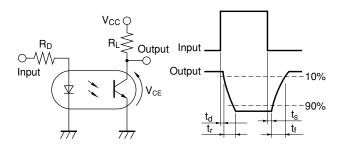
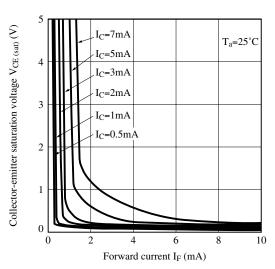


Fig.15 Test Circuit for Response Time



Please refer to the conditions in Fig.13 and Fig.14.

Fig.17 Collector-emitter Saturation Voltage vs. Forward Current



Remarks: Please be aware that all data in the graph are just for reference and not for guarantee.



#### ■ Design Considerations

#### Design guide

While operating at I<sub>F</sub><0.5mA, CTR variation may increase.

Please make design considering this fact.

In case that some sudden big noise caused by voltage variation is provided between primary and secondary terminals of photocoupler some current caused by it is floating capacitance may be generated and result in false operation since current may go through IRED or current may change.

If the photocoupler may be used under the circumstances where noise will be generated we recommend to use the bypass capacitors at the both ends of IRED.

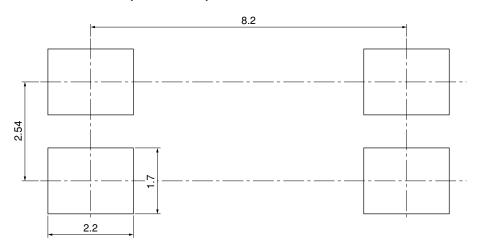
This product is not designed against irradiation and incorporates non-coherent IRED.

#### Degradation

In general, the emission of the IRED used in photocouplers will degrade over time.

In the case of long term operation, please take the general IRED degradation (50% degradation over 5 years) into the design consideration.

#### Recommended Foot Print (reference)



(Unit:mm)

<sup>☆</sup> For additional design assistance, please review our corresponding Optoelectronic Application Notes.



#### ■ Manufacturing Guidelines

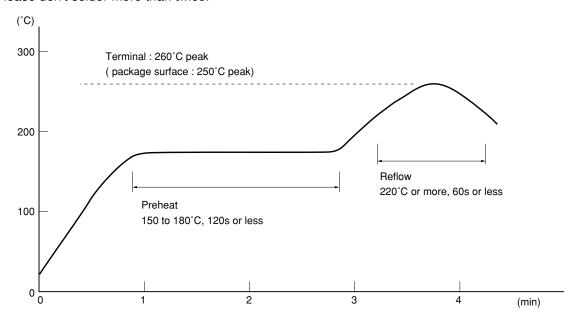
## Soldering Method

#### Reflow Soldering:

Reflow soldering should follow the temperature profile shown below.

Soldering should not exceed the curve of temperature profile and time.

Please don't solder more than twice.



#### Flow Soldering:

Due to SHARP's double transfer mold construction submersion in flow solder bath is allowed under the below listed guidelines.

Flow soldering should be completed below 270°C and within 10s.

Preheating is within the bounds of 100 to 150°C and 30 to 80s.

Please don't solder more than twice.

#### Hand soldering

Hand soldering should be completed within 3s when the point of solder iron is below 400°C.

Please don't solder more than twice.

#### Other notices

Please test the soldering method in actual condition and make sure the soldering works fine, since the impact on the junction between the device and PCB varies depending on the tooling and soldering conditions.



#### Cleaning instructions

#### Solvent cleaning:

Solvent temperature should be 45°C or below Immersion time should be 3 minutes or less

#### Ultrasonic cleaning:

The impact on the device varies depending on the size of the cleaning bath, ultrasonic output, cleaning time, size of PCB and mounting method of the device.

Therefore, please make sure the device withstands the ultrasonic cleaning in actual conditions in advance of mass production.

#### Recommended solvent materials:

Ethyl alcohol, Methyl alcohol and Isopropyl alcohol

In case the other type of solvent materials are intended to be used, please make sure they work fine in actual using conditions since some materials may erode the packaging resin.

#### Presence of ODC

This product shall not contain the following materials.

And they are not used in the production process for this product.

Regulation substances: CFCs, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methylchloroform)

Specific brominated flame retardants such as the PBBOs and PBBs are not used in this product at all.

This product shall not contain the following materials banned in the RoHS Directive (2002/95/EC).

•Lead, Mercury, Cadmium, Hexavalent chromium, Polybrominated biphenyls (PBB), Polybrominated diphenyl ethers (PBDE).



## ■ Package specification

## Sleeve package

Package materials

Sleeve: HIPS (with anti-static material)

Stopper: Styrene-Elastomer

## Package method

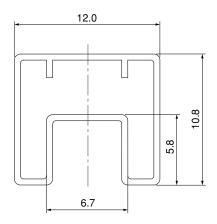
MAX. 100pcs of products shall be packaged in a sleeve.

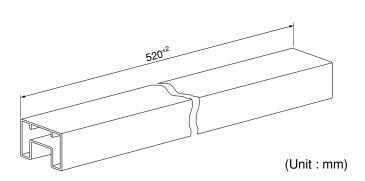
Both ends shall be closed by tabbed and tabless stoppers.

The product shall be arranged in the sleeve with its anode mark on the tabless stopper side.

MAX. 20 sleeves in one case.

#### Sleeve outline dimensions







## ● Tape and Reel package

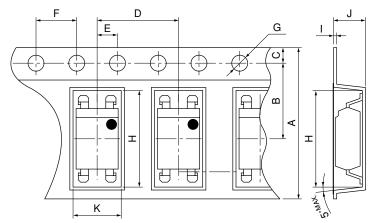
Package materials

Carrier tape: PS

Cover tape: PET (three layer system)

Reel: PS

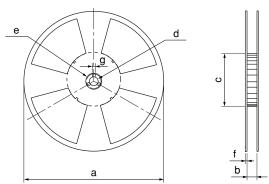
Carrier tape structure and Dimensions



**Dimensions List** 

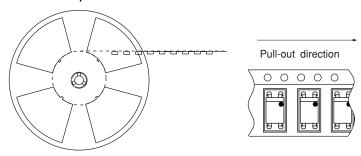
(Unit: mm) В C D Е F G  $7.5^{\pm0.1}$ 1.75<sup>±0.1</sup>  $2.0^{\pm0.1}$  $4.0^{\pm0.1}$ 16.0±0.3 8.0<sup>±0.1</sup>  $\phi 1.5^{+0.1}_{-0}$ Н K  $10.4^{\pm0.1}$  $0.4^{\pm0.05}$  $4.2^{\pm0.1}$  $5.1^{\pm0.1}$ 

#### Reel structure and Dimensions



Dimensio	ns List	(Unit: mm)		
a	b	с	d	
330	17.5 <sup>±1.5</sup>	100±1.0	13 <sup>±0.5</sup>	
e	f	g		
23±1.0	2.0±0.5	2.0±0.5		

# Direction of product insertion



[Packing: 2 000pcs/reel]



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- --- Alarm equipment
- --- Various safety devices, etc.
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[E187] Sheet No.: D2-A03302EN